

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	Page 1 of 1
		Raymond S. Dean	2618	

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*	B	US-6,925,113	08-2005	Kim et al.	375/227
*	C	US-2003/0050008	03-2003	Patterson et al.	455/12.1
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**NON-PATENT DOCUMENTS**

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